## Abstract Submitted for the MAR06 Meeting of The American Physical Society

All MgB<sub>2</sub> tunnel junction with Al<sub>2</sub>O<sub>3</sub> tunnel barrier<sup>1</sup> HEEJAE SHIM, JAGADEESH S. MOODERA, Francis Bitter Magnet Laboratory, MIT, Cambridge, MA — MgB<sub>2</sub> tunnel junctions are attractive not only from superconducting electronics application part of view but also from the fundamental physics to understand multi-gap superconductors. All MgB<sub>2</sub> planar junctions with Al<sub>2</sub>O<sub>3</sub> tunnel barrier were fabricated in situ in an MBE system by coevaporation of Mg and B for MgB<sub>2</sub> and plasma oxidized Al for tunnel barrier on Si (111) substrate. The junctions exhibit the current-voltage characteristic for quasiparticle and Josephson tunneling including microwave induced Shapiro steps. From conductance spectrum at 1 K, we clearly observe features that correspond to different  $\pi$  and  $\sigma$  superconducting energy gaps for the two MgB<sub>2</sub> electrodes. The observed multi-gap structure will be discussed with the difference of crystallographic orientation of MgB<sub>2</sub> at the interface between tunnel barrier and both superconducting layers.

<sup>1</sup>This work was supported by ONR Grant and H. Shim was supported by the Post-doctoral Fellowship Program of KOSEF.

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Date submitted: 30 Nov 2005 Electronic form version 1.4